Notice of References Cited	Application/Control No. 10/772,311	Applicant(s)/Patent Under Reexamination LEE ET AL.		
	Examiner	Art Unit	Page 1 of 1	
	EDMUND H. LEE	1791		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,635,220	06-1997	Izumi et al.	425/116
	В	US-			
	С	US-			
	ם	US-			
	Е	US-			
	F	US-			
	O	US-			
	Ι	US-			
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	K	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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